Dual 64-Bit Static Shift Register
MC14517B

The MC14517B dual 64-bit static shift register consists of two identical, independent, 64-bit registers. Each register has separate clock and write enable inputs, as well as outputs at bits 16, 32, 48, and 64. Data at the data input is entered by clocking, regardless of the state of the write enable input. An output is disabled (open circuited) when the write enable input is high. During this time, data appearing at the data input as well as the 16-bit, 32-bit, and 48-bit taps may be entered into the device by application of a clock pulse. This feature permits the register to be loaded with 64 bits in 16 clock periods, and also permits bus logic to be used. This device is useful in time delay circuits, temporary memory storage circuits, and other serial shift register applications.

Features

- Diode Protection on All Inputs
- Fully Static Operation
- Output Transitions Occur on the Rising Edge of the Clock Pulse
- Exceedingly Slow Input Transition Rates May Be Applied to the Clock Input
- 3-State Output at 64th-Bit Allows Use in Bus Logic Applications
- Shift Registers of any Length may be Fully Loaded with 16 Clock Pulses
- Supply Voltage Range = 3.0 Vdc to 18 Vdc
- Capable of Driving Two Low-Power TTL Loads or One Low-Power Schottky TTL Load Over the Rated Temperature Range
- NLV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- This Device is Pb-Free and is RoHS Compliant

MAXIMUM RATINGS (Voltages Referenced to V_{SS})

Parameter	Symbol	Value	Unit
DC Supply Voltage Range	V_{DD}	−0.5 to +18.0	V
Input or Output Voltage Range (DC or Transient)	V_{in}, V_{out}	−0.5 to V_{DD} + 0.5	V
Input or Output Current (DC or Transient) per Pin	I_{in}, I_{out}	±10	mA
Power Dissipation per Package (Note 2)	P_D	500	mW
Operating Temperature Range	T_A	−55 to +125	°C
Storage Temperature Range	T_{stg}	−65 to +150	°C
Lead Temperature (8-Second Soldering)	T_L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. Operating the device outside its recommended conditions, but still within its maximum rated limits may not cause immediate damage. However, doing so can lead to reduced performance, unpredictable behavior, and potentially shorten the device's lifespan or reliability.

2. Temperature Derating: Plastic "D/DW" Package: −7.0 mW/°C From 65 °C to 125 °C

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation, V_{in} and V_{out} should be constrained to the range $V_{SS} \leq (V_{in}$ or $V_{out}) \leq V_{DD}$.

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either V_{SS} or V_{DD}). Unused outputs must be left open.
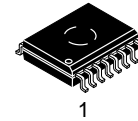
**SOIC-16 WB
DW SUFFIX
CASE 751G**

MARKING DIAGRAM

16
14517B
AWLYYWWG
1
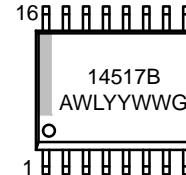
A	= Assembly Location
WL, L	= Wafer Lot
YY, Y	= Year
WW, W	= Work Week
G	= Pb-Free Package

PIN ASSIGNMENT

$Q16_A$	1	16	V_{DD}
$Q48_A$	2	15	$Q16_B$
WE_A	3	14	$Q48_B$
C_A	4	13	WE_B
$Q64_A$	5	12	C_B
$Q32_A$	6	11	$Q64_B$
D_A	7	10	$Q32_B$
V_{SS}	8	9	D_B

ORDERING INFORMATION

Device	Package	Shipping†
NLV14517BDWR2G	SOIC-16 WB (Pb-Free)	1000 / Tape & Reel
MC14517BDWR2G	SOIC-16 WB (Pb-Free)	1000 / Tape & Reel

DISCONTINUED (Note 1)

MC14517BDWG	SOIC-16 WB (Pb-Free)	47 Units/Rail

† For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

1. **DISCONTINUED:** This device is not recommended for new design. Please contact your **onsemi** representative for information. The most current information on this device may be available on www.onsemi.com.

MC14517B

FUNCTIONAL TRUTH TABLE (X = Don't Care)

Clock	Write Enable	Data	16-Bit Tap	32-Bit Tap	48-Bit Tap	64-Bit Tap
0	0	X	Content of 16-Bit Displayed	Content of 32-Bit Displayed	Content of 48-Bit Displayed	Content of 64-Bit Displayed
0	1	X	High Impedance	High Impedance	High Impedance	High Impedance
1	0	X	Content of 16-Bit Displayed	Content of 32-Bit Displayed	Content of 48-Bit Displayed	Content of 64-Bit Displayed
1	1	X	High Impedance	High Impedance	High Impedance	High Impedance
⎍	0	Data entered into 1st Bit	Content of 16-Bit Displayed	Content of 32-Bit Displayed	Content of 48-Bit Displayed	Content of 64-Bit Displayed
⎍	1	Data entered into 1st Bit	Data at tap entered into 17-Bit	Data at tap entered into 33-Bit	Data at tap entered into 49-Bit	High Impedance
�온	0	X	Content of 16-Bit Displayed	Content of 32-Bit Displayed	Content of 48-Bit Displayed	Content of 64-Bit Displayed
�온	1	X	High Impedance	High Impedance	High Impedance	High Impedance

ELECTRICAL CHARACTERISTICS (Voltages Referenced to V_{SS})

Characteristic	Symbol	V_{DD} Vdc	−55 °C Min	−55 °C Max	25 °C Min	25 °C Typ (Note 2)	25 °C Max	125 °C Min	125 °C Max	Unit
Output Voltage "0" Level $V_{in} = V_{DD}$ or 0	V_{OL}	5.0	–	0.05	–	0	0.05	–	0.05	Vdc
		10	–	0.05	–	0	0.05	–	0.05	
		15	–	0.05	–	0	0.05	–	0.05	
"1" Level $V_{in} = 0$ or V_{DD}	V_{OH}	5.0	4.95	–	4.95	5.0	–	4.95	–	Vdc
		10	9.95	–	9.95	10	–	9.95	–	
		15	14.95	–	14.95	15	–	14.95	–	
Input Voltage "0" Level (V_O = 4.5 or 0.5 Vdc) (V_O = 9.0 or 1.0 Vdc) (V_O = 13.5 or 1.5 Vdc)	V_{IL}	5.0	–	1.5	–	2.25	1.5	–	1.5	Vdc
		10	–	3.0	–	4.50	3.0	–	3.0	
		15	–	4.0	–	6.75	4.0	–	4.0	
"1" Level (V_O = 0.5 or 4.5 Vdc) (V_O = 1.0 or 9.0 Vdc) (V_O = 1.5 or 13.5 Vdc)	V_{IH}	5.0	3.5	–	3.5	2.75	–	3.5	–	Vdc
		10	7.0	–	7.0	5.50	–	7.0	–	
		15	11	–	11	8.25	–	11	–	
Output Drive Current (V_{OH} = 2.5 Vdc) Source (V_{OH} = 4.6 Vdc) (V_{OH} = 9.5 Vdc) (V_{OH} = 13.5 Vdc)	I_{OH}	5.0	−3.0	–	−2.4	−4.2	–	−1.7	–	mAdc
		5.0	−0.64	–	−0.51	−0.88	–	−0.36	–	
		10	−1.6	–	−1.3	−2.25	–	−0.9	–	
		15	−4.2	–	−3.4	−8.8	–	−2.4	–	
(V_{OL} = 0.4 Vdc) Sink (V_{OL} = 0.5 Vdc) (V_{OL} = 1.5 Vdc)	I_{OL}	5.0	0.64	–	0.51	0.88	–	0.36	–	mAdc
		10	1.6	–	1.3	2.25	–	0.9	–	
		15	4.2	–	3.4	8.8	–	2.4	–	
Input Current	I_{in}	15	–	±0.1	–	±0.00001	±0.1	–	±1.0	µAdc
Input Capacitance ($V_{in} = 0$)	C_{in}	–	–	–	–	5.0	7.5	–	–	pF
Quiescent Current (Per Package)	I_{DD}	5.0	–	5.0	–	0.005	5.0	–	150	µAdc
		10	–	10	–	0.010	10	–	300	
		15	–	20	–	0.015	20	–	600	
Total Supply Current (Note 4, 5) (Dynamic plus Quiescent, Per Package) (C_L = 50 pF on all outputs, all buffers switching)	I_T	5.0 10 15	$I_T = (4.2 \text{ µA/kHz}) f + I_{DD}$ $I_T = (8.8 \text{ µA/kHz}) f + I_{DD}$ $I_T = (13.7 \text{ µA/kHz}) f + I_{DD}$							µAdc
Three-State Leakage Current	I_{TL}	15	–	±0.1	–	±0.0001	±0.1	–	±3.0	µAdc

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
3. Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.
4. The formulas given are for the typical characteristics only at 25 °C.
5. To calculate total supply current at loads other than 50 pF: $I_T(C_L) = I_T(50 \text{ pF}) + (C_L − 50)$ Vfk where: I_T is in µA (per package), C_L in pF, V = ($V_{DD} − V_{SS}$) in volts, f in kHz is input frequency, and k = 0.004.

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Characteristic	Symbol	V_{DD}	Min	Typ (Note 7)	Max	Unit
Output Rise and Fall Time t_{TLH}, t_{THL} = (1.5 ns/pF) C_L + 25 ns t_{TLH}, t_{THL} = (0.75 ns/pF) C_L + 12.5 ns t_{TLH}, t_{THL} = (0.65 ns/pF) C_L + 9.5 ns	t_{TLH}, t_{THL}	5.0 10 15	– – –	100 50 40	200 100 80	ns
Propagation Delay Time t_{PLH}, t_{PHL} = (1.7 ns/pF) C_L + 390 ns t_{PLH}, t_{PHL} = (0.66 ns/pF) C_L + 177 ns t_{PLH}, t_{PHL} = (0.5 ns/pF) C_L + 115 ns	t_{PLH}, t_{PHL}	5.0 10 15	– – –	475 210 140	770 300 215	ns
Clock Pulse Width	t_{WH}	5.0 10 15	330 125 100	170 75 60	– – –	ns
Clock Pulse Frequency	f_{cl}	5.0 10 15	– – –	3.0 6.7 8.3	1.5 4.0 5.3	MHz
Clock Pulse Rise and Fall Time	t_{TLH}, t_{THL}	5.0 10 15	See (Note 8)			–
Data to Clock Setup Time	t_{su}	5.0 10 15	0 10 15	– 40 – 15 0	– – –	ns
Data to Clock Hold Time	t_h	5.0 10 15	150 75 35	75 25 10	– – –	ns
Write Enable to Clock Setup Time	t_{su}	5.0 10 15	400 200 110	170 65 50	– – –	ns
Write Enable to Clock Release Time	t_{rel}	5.0 10 15	380 180 100	160 55 40	– – –	ns

6. The formulas given are for the typical characteristics only at 25 °C.
7. Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.
8. When shift register sections are cascaded, the maximum rise and fall time of the clock input should be equal to or less than the rise and fall time of the data outputs, driving data inputs, plus the propagation delay of the output driving stage.
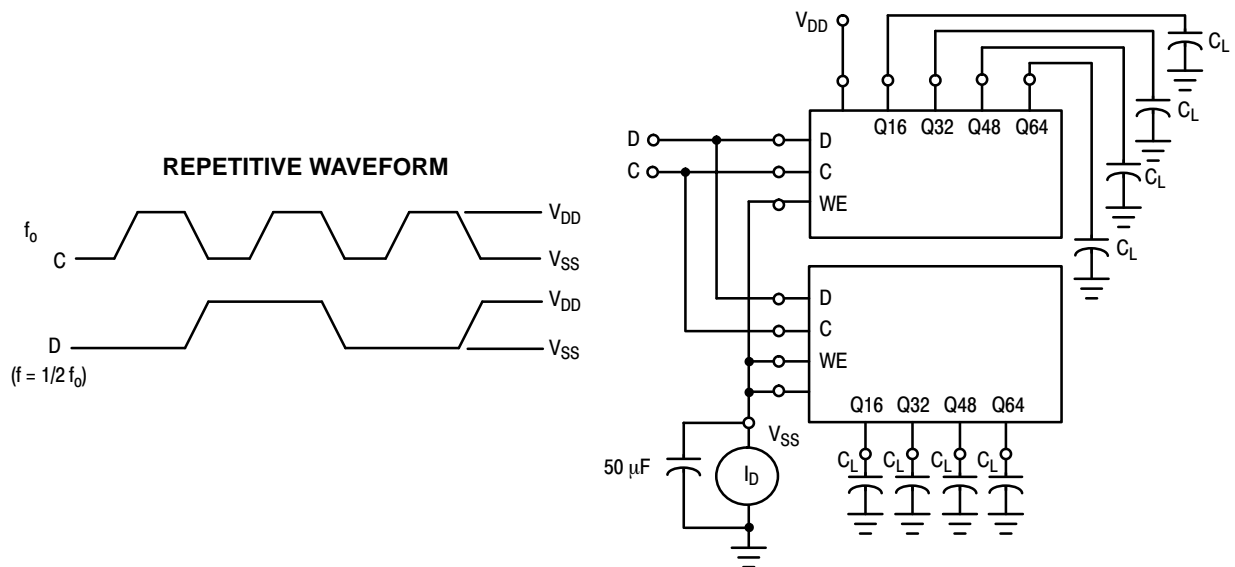
Figure 1. Power Dissipation Test Circuit and Waveform

MC14517B
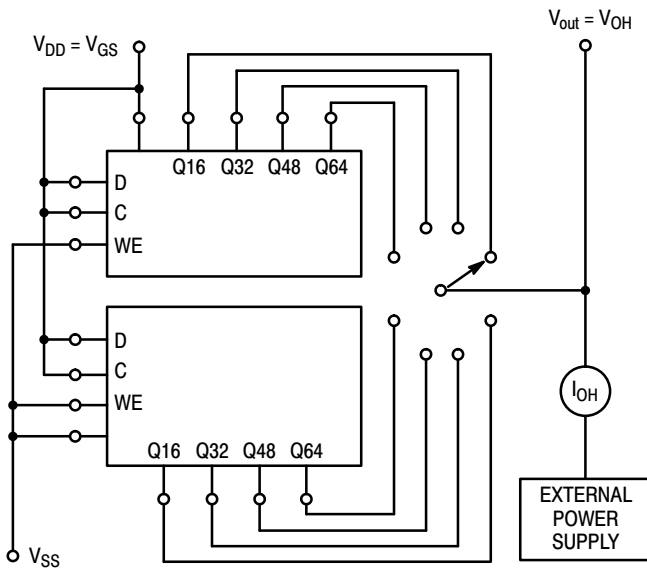
(Output being tested should be in the high-logic state)

Figure 2. Typical Output Source Current Characteristics Test Circuit
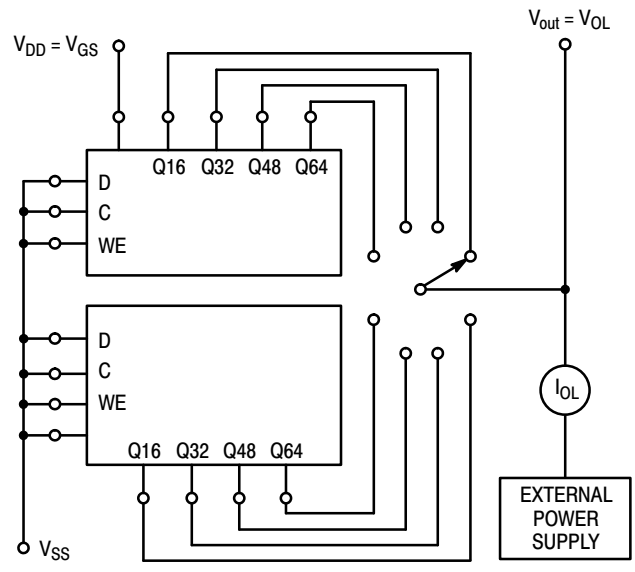
(Output being tested should be in the low-logic state)

Figure 3. Typical Output Sink Current Characteristics Test Circuit
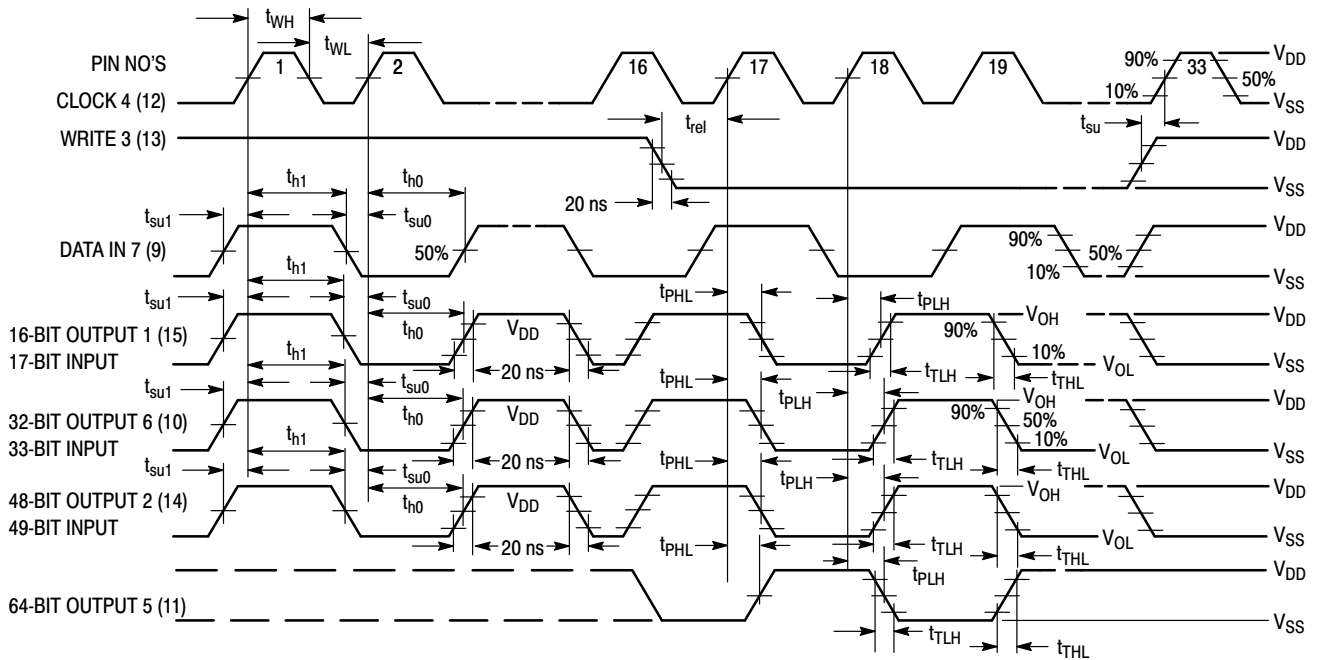
Figure 4. AC Test Waveforms

EXPANDED BLOCK DIAGRAM (1/2 OF DEVICE SHOWN)
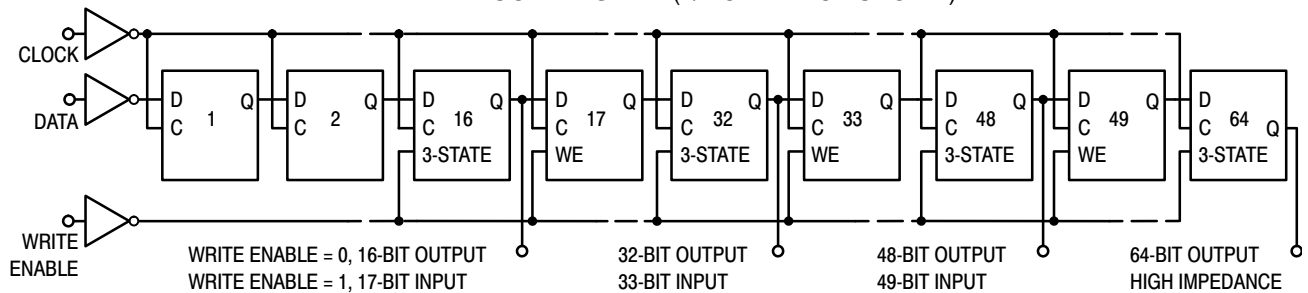
WRITE ENABLE = 0, 16-BIT OUTPUT
WRITE ENABLE = 1, 17-BIT INPUT

32-BIT OUTPUT
33-BIT INPUT

48-BIT OUTPUT
49-BIT INPUT

64-BIT OUTPUT
HIGH IMPEDANCE

MC14517B

SOIC−16 WB
CASE 751G
ISSUE E

DATE 08 OCT 2021
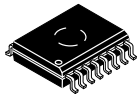
SCALE 1:1
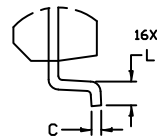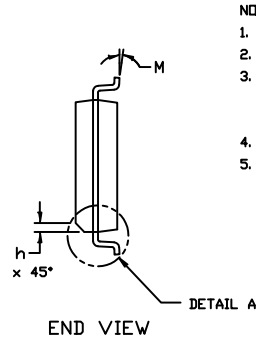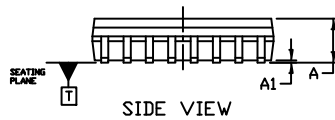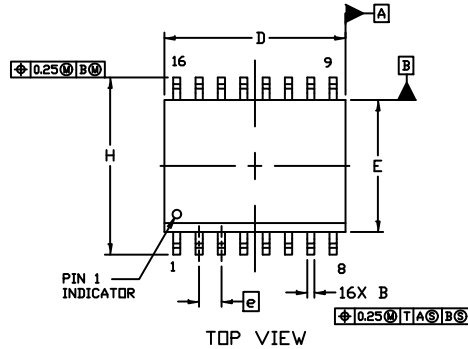
NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF B DIMENSION AT MAXIMUM MATERIAL CONDITION.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD PROTRUSIONS.
5. MAXIMUM MOLD PROTRUSION OR FLASH TO BE 0.15 PER SIDE.

DIM	MILLIMETERS	
	MIN.	MAX.
A	2.35	2.65
A1	0.10	0.25
B	0.35	0.49
C	0.23	0.32
D	10.15	10.45
E	7.40	7.60
e	1.27 BSC	
H	10.05	10.55
h	0.53 REF	
L	0.50	0.90
M	0°	7°

TOP VIEW

END VIEW

DETAIL A

SIDE VIEW

DETAIL A
2X SCALE

**GENERIC
MARKING DIAGRAM***

XXXXXXXXXXX
XXXXXXXXXXX
AWLYYWWG
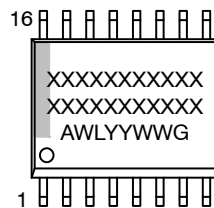
XXXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week
G = Pb−Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

16X 0.58
11.00
16X 1.62
1.27
PITCH
**RECOMMENDED
MOUNTING FOOTPRINT**
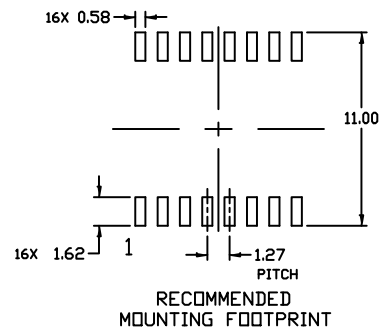
DOCUMENT NUMBER:	98ASB42567B	
DESCRIPTION:	SOIC−16 WB	PAGE 1 OF 1

ADDITIONAL INFORMATION

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